

**Notice of References Cited**

Application/Control No.

10/564,677

Applicant(s)/Patent Under  
Reexamination  
KRANZ ET AL.

Examiner

MICHAEL B. NELSON

Art Unit

1794

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,046,951	09-1977	Stefanik, John E.	428/412
	B	US-			
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	E	US-			
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	K	US-			
	L	US-			
	M	US-			

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	N	WO 01/096104	05-2001	WO	Liu et al.	
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**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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